### OVLAW4CB7

#### Features:

- High luminous intensity
- Through-hole type
- Clear lens
- High efficiency

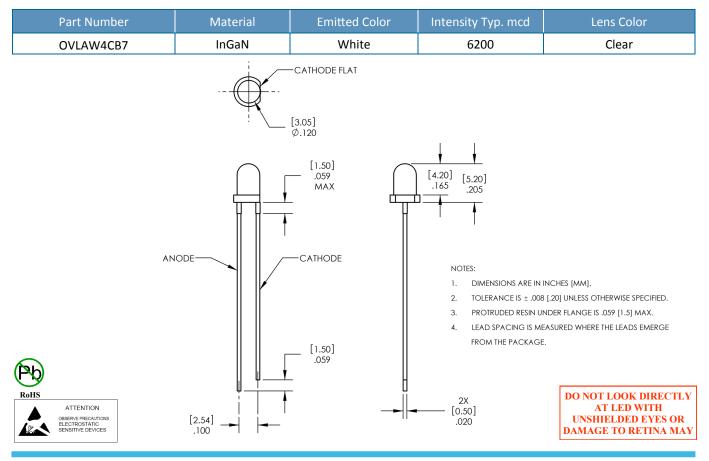


#### **Description:**

The OVLAW4CB7 is a round 3mm white high-intensity through-hole lamp with a 40° viewing angle. It is designed for wideangle uniform light output.

#### **Applications:**

- Indicators for medical, industrial, consumer and office equipment
- Indicators for white goods and home appliances
- Interior and exterior architectural and accent lighting
- Signs and digital information displays, video screen non-color and RGB presentation
- Automotive backlighting and indicators



#### General Note

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## OVLAW4CB7

### **Electrical Specifications**

#### Absolute Maximum Ratings (T<sub>A</sub> = 25° C unless otherwise noted)

Storage Temperature Range	-40 ~ +100° C
Operating Temperature Range	-40 ~ +100° C
Reverse Voltage	5 V
Power Dissipation	100 mW
Average Forward Current	25 mA
Peak Forward Current (Duty Ratio = 1/10, Pulse Width =0.1ms)	100 mA
Current Linearity vs Ambient Temperature	-0.29 mA/° C
LED Junction Temperature	125° C
Electrostatic Discharge Classification (JEDEC-JESD22-A114F)	Class 1C
Lead Soldering Temperature (5 seconds maximum)	260° C
Lead Soldering Temperature (5 seconds maximum)	260° C

### Electrical Characteristics (T<sub>A</sub> = 25° C unless otherwise noted)

SYMBOL	PARAMETER	MIN	ТҮР	ΜΑΧ	UNITS	TEST CONDITIONS
Ιv	Luminous Intensity	4,360	6,200		mcd	I <sub>F</sub> = 20 mA
20½	50% Power Angle		40		deg	I <sub>F</sub> = 20 mA
V <sub>F</sub>	Forward Voltage		3.2	4.0	V	I <sub>F</sub> = 20 mA
I <sub>R</sub>	Reverse Current			10	μΑ	$V_R = 5 V$
x	Chromaticity Coordinates		0.31			I <sub>F</sub> = 20 mA
У	Chromaticity Coordinates		0.32			I <sub>F</sub> = 20 mA

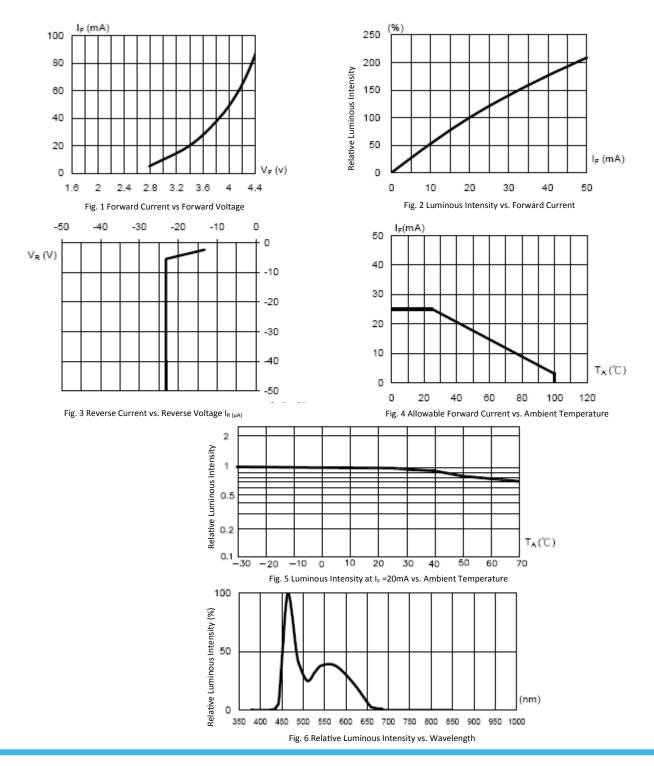
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### **Typical Electro-Optical Characteristics Curves**



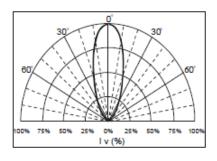
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## OVLAW4CB7

### Beam Pattern



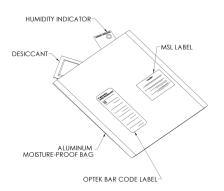
### Soldering:

Soldering heat may damage the LED. Careful attention should be paid during the soldering process and PCB assembly. In order to eliminate the stress of heat shock, please solder the LEDs no closer than 3mm from the base of the epoxy bulb.

### **Recommended Soldering Conditions:**

	Wave Soldering	Manual Solder Dipping	Hand Soldering by Iron
Pre-heat Temperature	105°C Max		
Pre-heat Time	30 seconds Max		
Peak Temperature	250°C Max	260°C Max	350°C Max
Dwell Time	3 seconds Max	5 seconds Max	3 seconds Max

### Packaging: 500 pcs per bulk bag



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## OVLAW4CB7

### **Reliability Test**

LED lamps are checked by reliability tests based on MIL standards.

### 1. Test Conditions, Acceptable Criteria & Results:

Classi- fication	Test Item	Standard Test Method	Test Conditions	Duration	Unit	Acc / Rej Criteria	Result
Life	Operation Life Test	MIL-STD-750D	T <sub>A</sub> =25°C → I <sub>F</sub> =30mA *	1000 Hrs	100	0 / 1	Pass
Test	(OLT)	Method 1026.3					
	High Temperature	MIL-STD-750D	T <sub>A</sub> =100°C	1000 Hrs	100	0 / 1	Pass
	Storage (HTS)	Method 1032.1					
	Low Temperature	MIL-STD-750D	T <sub>A</sub> =-40°C	1000 Hrs	100	0/1	Pass
Test	Storage (LTS)	Method 1032.1	1 <sub>A</sub> 40 C				
ent	Temp. & Humidity	MIL-STD-750D		500 Hrs	100	0 / 1	Pass
Environment Test	with Bias (THB)	Method 103B	T <sub>A</sub> =85°C > Rh=85% I <sub>F</sub> =20mA **				
	Thermal Shock	MIL-STD-750D	0°C ~ 100°C	100	100	0 / 1	Pass
	Test (TST)	Method 1056.1	2min 2min	cycles			
	Temperature	MIL-STD-750D	-40°C ~25°C~100°C ~25°C	100			_
	Cycling Test (TCT)	Method 1051.5	30min 5min 30min 5min	cycles	100	0 / 1	Pass
Mechanical Test	Solderability	MIL-STD-750D	235±5°C , 5 sec	1 time	20	0 / 1	Pass
		Method 2026.4	235 <u>+</u> 5 (, , ) sec				
	Resistance to	MIL-STD-750D	260.500 5	1 time	20	0 / 1	Pass
	Soldering Heat	Method 2031.1	260±5°C • 5 sec				
		MIL-STD-750D	Load 2.5N (0.25kgf)	3 times	20	0 / 1	Pass
	Lead Integrity	Method 2036.3	0°~90°~0° → bend				

Remark : (\*) IF =30mA for AlInGaP chip : IF =20mA for InGaN chip

(\*\*)  $I_F = 20 \text{mA}$  for AlInGaP chip ;  $I_F = 10 \text{mA}$  for InGaN chip

### 2. Failure Criteria (T<sub>A</sub> =25°C):

Test Item	Symbol	Test Conditions	Criteria for Judgment			
			Min.	Max.		
Luminous Intensity	$I_V$	$I_F = 20 \text{ mA}$	LSL×0.7 **			
Forward Voltage	Vf	I <sub>F</sub> =20 mA		USL×1.1 *		

(\*) USL : Upper Standard Level , (\*\*) LSL : Lower Standard Level

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